

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ONISHI ET AL.	
		09/786,680	Examiner	Art Unit
Cheukfan Lee		2622	Page 1 of 1	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,496,285	12-2002	Fujimoto et al.	358/475
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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